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AON7406

30V N-Channel MOSFET

General Description

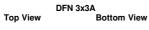
- The AON7406 uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. This device is suitable for use in SMPS and general purpose applications.
- RoHS and Halogen-Free Compliant

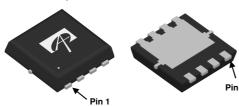
Product Summary

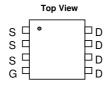
 $\begin{array}{lll} V_{DS} & 30V \\ I_D & (at \ V_{GS}{=}10V) & 25A \\ R_{DS(ON)} & (at \ V_{GS}{=}10V) & <17 m\Omega \\ R_{DS(ON)} & (at \ V_{GS}{=}4.5V) & <23 m\Omega \\ Typical \ ESD \ protection & HBM \ Class \ 2 \end{array}$

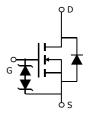
100% UIS Tested 100% R_g Tested











Absolute Maximum Ratings T_A=25℃ unless otherwise noted

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V _{DS}	30	V	
Gate-Source Voltage		V_{GS}	±20	V	
Continuous Drain	T _C =25℃	1	25		
Current	T _C =100℃	'D	15	A	
Pulsed Drain Current ^C		I _{DM}	50		
Continuous Drain	T _A =25℃	1	9	^	
Current	T _A =70℃	IDSM	7	A	
Avalanche Current ^C		I _{AS} , I _{AR}	19	A	
Avalanche energy L=0.1mH ^C		E _{AS} , E _{AR}	18	mJ	
	T _C =25℃	P _D	15.5	W	
Power Dissipation ^B	T _C =100℃	T D	6	VV	
	T _A =25℃	D	3.1	w	
Power Dissipation ^A	T _A =70℃	P _{DSM}	2	VV	
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	C	

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	D	30	40				
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	60	75				
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	6.6	8	℃/W			



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units				
STATIC PARAMETERS										
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D=250\mu A,\ V_{GS}=0V$	30			V				
I _{DSS}	Zero Gate Voltage Drain Current	V_{DS} =30V, V_{GS} =0V T_{J} =55 C			1 5	μΑ				
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} = ±16V			10	μΑ				
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ $I_{D}=250\mu A$	1.2	1.8	2.4	·V				
I _{D(ON)}	On state drain current	$V_{GS}=10V$, $V_{DS}=5V$	50			Α				
	Static Drain-Source On-Resistance	$V_{GS}=10V$, $I_D=9A$		14	17					
		T _J =125℃		20	24	mΩ				
		V _{GS} =4.5V, I _D =8A		18	23	mΩ				
g _{FS}	Forward Transconductance	$V_{DS}=5V$, $I_{D}=9A$		40		S				
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V		0.75	1	V				
Is	Maximum Body-Diode Continuous Curr			15	Α					
DYNAMIC	PARAMETERS									
C _{iss}	Input Capacitance		600	740	888	рF				
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =15V, f=1MHz	77	110	145	pF				
C _{rss}	Reverse Transfer Capacitance		50	82	115	pF				
R_g	Gate resistance	V_{GS} =0V, V_{DS} =0V, f=1MHz	0.5	1.1	1.7	Ω				
SWITCHI	NG PARAMETERS									
Q _g (10V)	Total Gate Charge		12	15	18	nC				
Q _g (4.5V)	Total Gate Charge	V _{GS} =10V, V _{DS} =15V, I _D =9A	6	7.5	9	nC				
Q_{gs}	Gate Source Charge	VGS-10V, VDS-13V, ID-3A		2.5		nC				
Q_{gd}	Gate Drain Charge			3		nC				
$t_{D(on)}$	Turn-On DelayTime			5		ns				
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =15V, R_L =1.67 Ω ,		3.5		ns				
$t_{D(off)}$	Turn-Off DelayTime	$R_{GEN}=3\Omega$		19		ns				
t _f	Turn-Off Fall Time			3.5		ns				
t _{rr}	Body Diode Reverse Recovery Time	I_F =9A, dI/dt=500A/ μ s	6	8	10	ns				
Q_{rr}	Body Diode Reverse Recovery Charge	I_F =9A, dI/dt=500A/ μ s	14	18	22	nC				

A. The value of R_{BJA} is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R_{BJA} t $\leq 10\text{s}$ value and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

- D. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to case $R_{\theta JC}$ and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

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B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}$ =150° C. Ratings are based on low frequency and duty cycles to keep initial T_J =25° C.

F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}=150^{\circ}$ C. The SOA curve provides a single pulse rating.

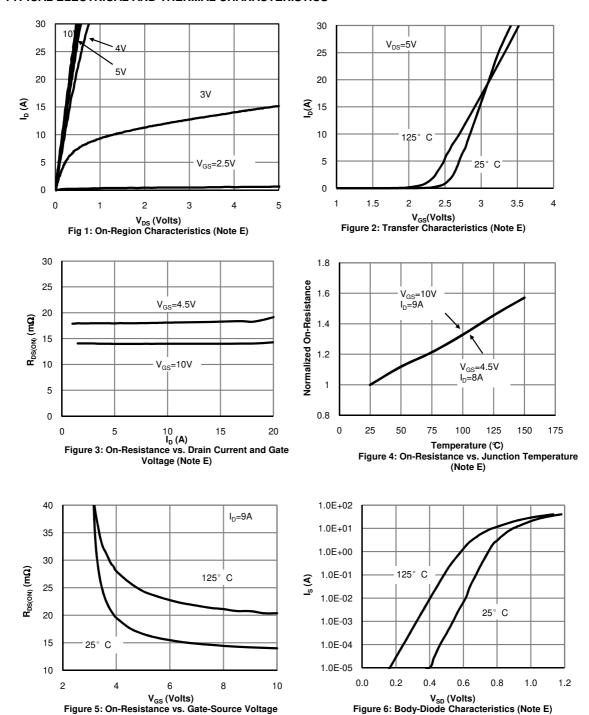
G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^{\circ}\,$ C.



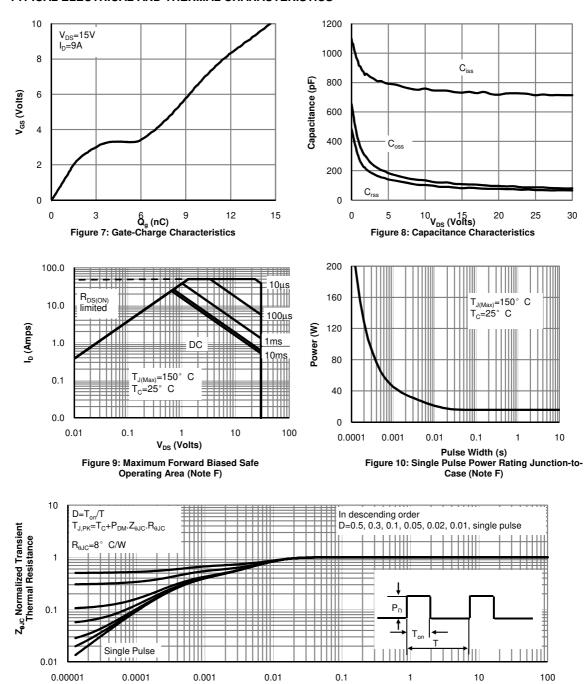
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

(Note E)





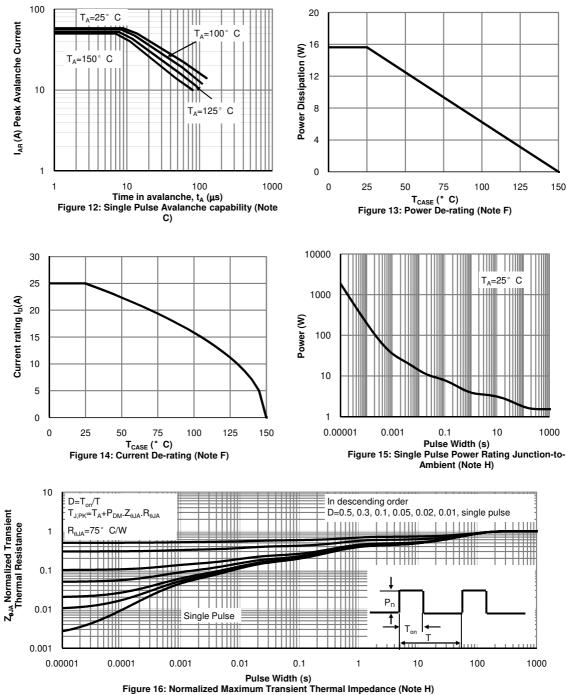
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

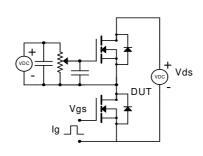


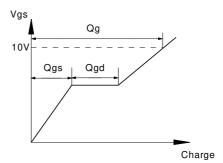
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



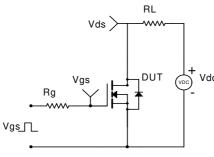


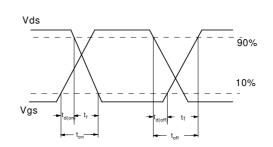
Gate Charge Test Circuit & Waveform



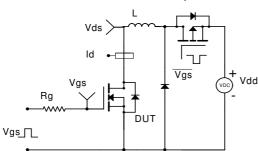


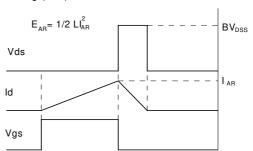
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

